Special Test Request Form		STR Number 14
Part 1 – Test Definition Section		
Test Title: Trigger Timing Scans: TKR TACK and TEM Diagnostics Latching	Test Requ	estor: Su Dong
 Test Purpose and Justification: This STR proposal has two parts: 1) To make a controlled TACK scan latching, 2) and a timing scan of the TEM diagnostic data latching. 1. The existing standard trigger TACK scan test uses the TKR tr save testing time. The TKR trigger delay unfortunately doesn' it cannot reach earlier times when signal latching drop. This S only to gather a consistent set of data, including the very early for TACK settings in various TKR standard tests to allow the related tests to closely follow that for the equivalent setting fo currently being held until we obtain some results from this ST 2. There also have been confusion regarding the interpretation of scan of the TEM diagnostic data latching delay and stretch wi obtain an optimized best setup for the diagnostic data. 	a for more pr igger itself t 't allow one TR proposa time points TACK setti or real muons 'R. of TEM diag Il allow a m	recise optimization of TKR signal o get a faster data collection to to see the TACK peak clearly as l is to use muon telescope trigger s. The result of this is important ngs for various charge injection s. Some standard TKR tests are nostic data recently. A systematic ore precise understanding and
 Test Description: These tests include 2 parts: TKR TACK scan with muon telescope: Based on the present trigger TACK scan test setup and operate muon telescope placed vertically above and below the tower. GEM TREQ delay for EXT set to zero. Set the GEM trigger v TKR TACK=0,5,10,15,20 with 10,000 muon telescope trigger online and offline to determine the optimal TACK setting. To TEM diagnostic data latching test: Based on present trigger efficiency test setup and operate on a muon telescope (vertical over tower 1), CAL and TKR trigger TEM diagnostic data latching settings. We envisage to take d configurations (CAL and TKR adjusted simultaneously) with hours. 	e on one sele Trigger on r vindow widt rs per point. tal time ~9 h all towers wh tat take mu ata at 8 diffe 20 min data	ected tower (tower 1) and with nuon telescope only, with the th to minimum. Scan through Examine TKR hit multiplicity nours. hich are available in the grid. Use non data from all towers at various erent diagnostic data latching at each point. Total test time ~3
GSE Configuration : GASU based teststand and the muon telescope at building 33. Muon te	lescope is p	laced vertically over tower 1.
LAT Configuration : The tower in bay 1 is required. The test is to be run with any other tower of 6 towers is expected, but not required. Both tests should have the on	ers available e-shot enabl	e at the time of execution. A total led with the baseline value.
Expected Results/Acceptance Criteria:		
Expected results: Optimized TKR TACK setting and optimized TEM Recommendation for the one-shot duration that has the highest capture	trigger diag	nostic data latching settings.
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Expected Duration:

12 hours, not including overhead. However, the two tests can be scheduled in two separate sessions.

Expected Analysis Duration:

Part of results will be available online. Offline results 1 week after test completion. The one-shot duration recommendation will be available one working day after the completion of the test.

Test Procedure:

Similar procedure as official trigger tests, with only adjustments of trigger delay and diagnostic data latching parameters online, by Hiro Tajima or Martin Kocian.

Test Script:

Test scripts are the official trigger scripts:

Test 1) TRG/Scripts/multiTowerTimeInSuite.py

Test 2) TRG/Scripts/triggerdata.py

Part 2 – Impact Assessment Section

Procedure development:

The procedure is the similar to existing trigger tests for test, only a few configuration parameters need to be altered for each test.

Script development and checkout:

Test scripts are the standard trigger test scripts already in place.

Impact to schedule:

The total testing time is ~ 2 shifts.

Risk Assessment:

Procedure does not have additional risks beyond the standard trigger tests.

Required Resources:

GASU based teststand, muon telescope and TKR charge injection associated equipment at building 33. Muon telescope is needed for the two tests. Needs Hiro Tajima or Martin Kocian to be present for parameter changes. Needs presence of an operator for equipment power on/off at start and end of the test.

Other Affected Parties:

Part 3: Signature Approval:				
Required Authorizations	Printed Name	Signature	Date	
Quality	Joe Cullinan	(Signature on file)	6/29/05	
I&T	Elliott Bloom	(Signature on file)	6/28/05	
Program Office	Lowell Klaisner or Dick Horn	(Signature on file)	6/28/05	
Systems Engineering	Pat Hascall	(Signature on file)	6/29/05	
Affected S/S managers	N/A			
Instrument Scientist	Steve Ritz or Eduardo do Couto e Silva	(Signature on file)	6/28/05	
DAQ	Mike Huffer	(Signature on file)	6/28/05	
Other	N/A			
Other	N/A			
Other	N/A			